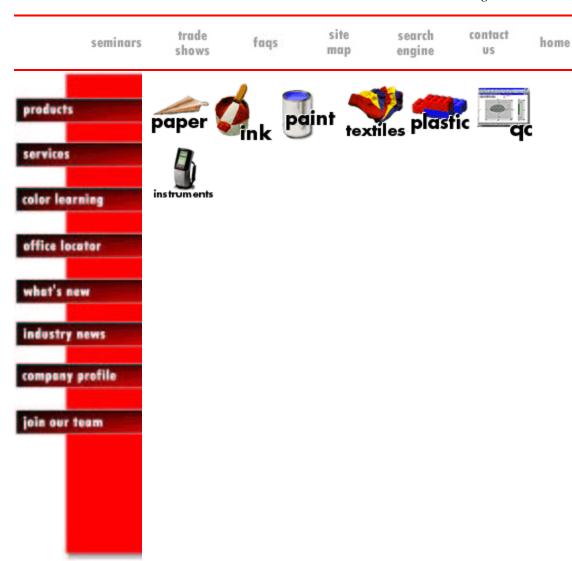
The world's leading supplier of instruments, software and systems for color control and color management in industry.



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SPECTRAFLASH SF450®

The Affordable Reference Spectrophotometer for Industrial Measurement

The Spectraflash SF450 is a high performance spectrophotometer suitable for either reference laboratory or routine production color operations. It is based on the optical and measuring systems of the proven Spectraflash SF600 Plus and its measurements are data compatible with any SP 2000 or MC-90 Datacolor instrument.

The SF450 employs a pulsed Xenon light source to illuminate a 6 inch (152mm) diameter integrating sphere that provides sample illumination. Sample viewing is accomplished through a high quality optical system featuring an automated zoom lens.

The SF450's dual beam SP 2000 Spectrophotometer measures both the sample and the reference beams using a matched pair of 256 diode arrays. Wavelength discrimination is accomplished by a precision holographic diffraction grating.

The SF450 utilizes measurement systems normally found in more expensive spectrophotometers and is an excellent choice whenever high performance color measurement is needed at an affordable cost.

SF450 Features:

- Available in either horizontal or vertical measuring orientations
- Automatic (motorized) specular included or excluded
- Automatic (motorized) zoom lens
- Optional automatic (motorized) UV Control and Cutoff Filters
- Compact rugged design suitable for the laboratory or production environment
- SP 2000 Spectrophotometer with dual 256 diode arrays and high resolution
- Full data compatibility with all Datacolor SP 2000 or MC-90 instruments
- Measuring areas: LAV, SAV, USAV
- Excellent inter-instrument agreement (reproducibility)
- · Excellent inter-lens agreement

Product Information

Options

Technical Data

Physical/Electrical

Product Information

Measurement Diffuse/8° Geometry

Illumination Source Pulsed Xenon Lamp filtered to D65 152 mm (6 inch); coated with BASO $_{\Delta}$ **Integrating Sphere**

Measurement Principle Dual-beam

Viewing Lens Automatic Zoom Switching

Specular Factor Automatic Included or Excluded

SP2000 Analyzer with two photodiode arrays and Spectrophotometer

holographic grating

- LAV - 30 mm illuminate/26 mm view Measuring Apertures

- SAV - 9 mm illuminate/5 mm view

- USAV - 6.5 mm illuminate/2.5 mm view

Options

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Automatic UV Automatic UV Calibration for the measurement and control of fluorescent samples with UV cut-off filters at: 400nm,

420 nm, and 460 nm

Vertical Orientation Vertical Orientation with Pedestal

Technical Data

Spectral Range 360-700 nm

Wavelength
Resolution

Wavelength Interval
Wavelength
Bandpass

2 nm (measured)
10 nm (reported)
10 nm (Reported)

Photometric Range 0-200% Photometric Resolution 0.003%

20 Read 0.02 △E CIELAB Maximum (On the white tile, dual

Repeatability flash)

Physical Electrical

 Size (Horizontal Model)
 47.0 x 29.2 x 30.0 cm

 Model)
 (18.5 x 11.5 x 11.8 inch)

 Size (Vertical Model)
 59.7 x 29.2 x 35.6 cm

(23.5 x 11.5 x 14.0 inch)

Weight (Horizontal

Model)

14 kg (31 lb)

Weight (Vertical

Model)

17 kg (38 lb)

Power 100 to 240 VAC, 47 to 63 Hz, 100 VA

Environment 5 to 40°C, 20 to 85% RH

For more additional information, contact our Datacolor product managers.

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